Search Notes

Applica	tion/C	ontrol	No.
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10/600,931 Examiner

Cuong Q. Nguyen

Applicant(s)/Patent	unde
Reexaminat	tion	

SHIN ET AL.

Art Unit

2811

SEARCHED			
Class	Subclass	Date	Examiner
157	777 678 678 723	7-19-05	a
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
25	678	7-19.05	a	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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